NX5L2750CGU

Analog switch with negative swing audio capability Rev. 2.1 — 12 February 2020 Produ

Product data sheet

General description 1

The NX5L2750CGU is a dual low-ohmic single-pole double-throw analog switch suitable for use as an analog or digital 2:1 multiplexer/demultiplexer. Each switch has a digital select input (nS), two independent inputs/outputs (nY0 and nY1) and a common input/ output (nZ).

The NX5L2750CGU is capable of switching audio signals with negative swing without the need of a coupling capacitor.

Schmitt trigger action at the digital inputs makes the circuit tolerant to slower input rise and fall times. Low threshold digital inputs allows this device to be driven by 1.8 V logic levels in 3.3 V applications without significant increase in supply current I_{CC}. This makes it possible for the NX5L2750CGU to switch 5 V audio signals with a 1.8 V digital controller, eliminating the need for logic level translation.

Features and benefits

- Supply voltage range from 1.8 V to 5.0 V
- 0.8 Ω typical ON resistance
- 100 MHz typical bandwidth or data frequency
- CMOS low-power consumption
- 1.8 V control logic at V_{CC} = 3.6 V
- · Break-before-make switching
- ESD protection:
 - HBM JESD22-A114F Class 3A exceeds 4000 V
 - CDM AEC-Q100-011 revision B exceeds 1000 V
- Latch-up performance exceeds 100 mA per JESD 78 Class II Level A
- Specified from -40 °C to +85 °C

Applications

- · Cellular phones, PDA
- Portable media players
- Personal media players



4 Ordering information

Table 1. Ordering information

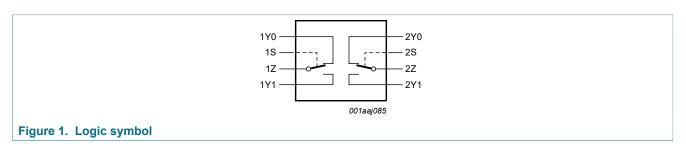
Type number	Topside	Package					
	marking	Name	Description	Version			
NX5L2750CGU	LA	XQFN10	plastic, extremely thin quad flat package; no leads; 10 terminals; body 1.40 x 1.80 x 0.50 mm	SOT1160-1			

4.1 Ordering options

Table 2. Ordering options

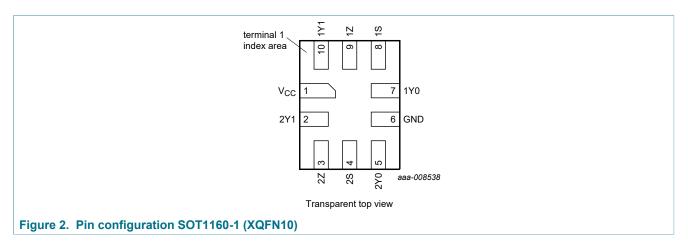
Type number	Orderable part number	Package	Packing method	Minimum order quantity	Temperature
NX5L2750CGU	NX5L2750CGUX	XQFN10	REEL 7" Q1 NDP	4000	T_{amb} = -40 °C to +85 °C

5 Functional diagram



6 Pinning information

6.1 Pinning



6.2 Pin description

Table 3. Pin description

Symbol	Pin	Description
-		· · · · · · · · · · · · · · · · · · ·
V _{CC}	1	supply voltage
2Y0, 1Y0	5, 7	independent input or output
2Z, 1Z	3, 9	common output or input
2S, 1S	4, 8	select input
GND	6	ground (0 V)
2Y1, 1Y1	2, 10	independent input or output

7 Functional description

Table 4. Function table^[1]

Table II Talletion table	
Input	Channel on
nS	
L	nY0 = nZ
Н	nY1 = nZ

^[1] H = HIGH voltage level; L = LOW voltage level.

8 Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{CC}	supply voltage			-0.5	+5.5	V
VI	input voltage	pins nS	[1]	-0.5	+5.5	V
V _{SW}	switch voltage			-4.0	V _{CC} + 0.5	V
I _{IK}	input clamping current	V _I < -0.5 V		-50	-	mA
I _{SK}	switch clamping current	$V_{I} < -4.0 \text{ V or } V_{I} > V_{CC} + 0.5 \text{ V}$		-	±50	mA
I _{SW}	switch current	T _{amb} = 25 °C		-	±250	mA
		T _{amb} = 25 °C; peak current (pulsed at 1 ms duration; < 10 % duty cycle)		-	±500	mA
I _{CC}	supply current			-	+50	mA
T _{stg}	storage temperature			-65	+150	°C
P _{tot}	total power dissipation	T _{amb} = -40 °C to +85 °C		-	250	mW

^[1] The minimum input voltage rating may be exceeded if the input current rating is observed.

9 Recommended operating conditions

Table 6. Recommended operating conditions

Symbol	Parameter	Conditions		Min	Max	Unit
V _{CC}	supply voltage			1.8	5.0	V
VI	input voltage	pins nS		0	5.0	V
V _{SW}	switch voltage		[1]	-2.5	V _{CC}	V
T _{amb}	ambient temperature			-40	+85	°C

^[1] The voltage across the switch should be < 5.5 V.

10 Static characteristics

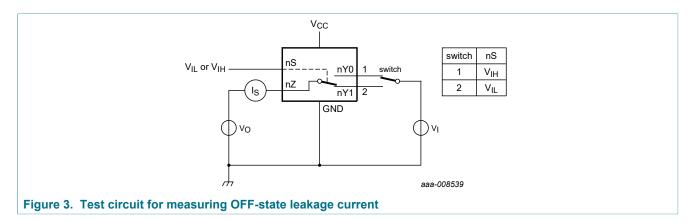
Table 7. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground 0 V).

Symbol	Parameter	Conditions	T _{amb}	= -40 °C to -	+85 °C	Unit
			Min	Typ ^[1]	Max	
V _{IH}	HIGH-level input	V _{CC} = 2.7 V to 4.3 V	1.4	-	-	V
	voltage	V _{CC} = 4.3 V to 5.0 V	1.5	-	-	V
V _{IL}	LOW-level input	V _{CC} = 2.7 V to 4.3 V	-	-	0.6	V
	voltage	V _{CC} = 4.3 V to 5.0 V	-	-	0.6	V
V _{IK}	input clamping voltage	V _{CC} = 3.0 V; I _I = -18 mA	-	-	-1.2	V
I _I	input leakage current	pins nS; $V_I = 0 \text{ V to } V_{CC}$; $V_{CC} = 0 \text{ V to } 4.3 \text{ V}$	-	-	±1	μA
I _{S(OFF)}	OFF-state leakage current	V _{CC} = 2.7 V; V _I = -2.5 V or 2.5 V; V _O = 2.5 V or -2.5 V; see <u>Figure 3</u>	-	-	±250	nA
I _{CC}	supply current	$V_I = V_{CC}$ or GND; $V_{SW} = GND$ or V_{CC} ; $V_{CC} = 2.7 \text{ V}$			2	μΑ
ΔI _{CC}	additional supply current	V_{I} = 2.6 V; V_{SW} = GND or V_{CC} ; V_{CC} = 4.3 V	-	-	10	μA
		V_{I} = 1.8 V; V_{SW} = GND or V_{CC} ; V_{CC} = 4.3 V	-	-	15	μA
C _I	input capacitance	pins nS	-	1.5	-	pF
C _{S(OFF)}	OFF-state capacitance	pins nY0 and nY1; V _{CC} = 3.3 V; V _I = 0 V to 3.3 V	-	35	-	pF
C _{S(ON)}	ON-state capacitance	pins nZ; V _{CC} = 3.3 V; V _I = 0 V to 3.3 V	-	75	-	pF

^[1] Typical values are measured at T_{amb} = 25 °C and V_{CC} = 3.3 V.

10.1 Test circuits



10.2 ON resistance

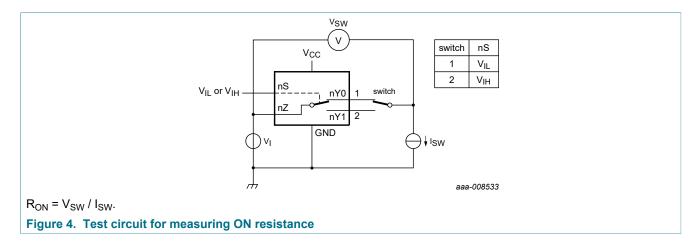
Table 8. ON resistance

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions ^[1]	-40 °C to +85 °C		°C	Unit	
				Min	Typ ^[2]	Max	
R _{ON}	ON resistance	V_1 = V_{CC} -4.5 V to V_{CC} ; I_{SW} = 100 mA; V_{CC} = 2.7 V; see Figure 4		-	0.8	1.3	Ω
R _{ON(flat)}	ON resistance (flatness)	V_I = V_{CC} -4.5 V to V_{CC} ; I_{SW} = 100 mA; V_{CC} = 2.7 V; see Figure 4		-	0.3	-	Ω
ΔR _{ON}	ON resistance mismatch between channels	$V_1 = V_{CC}$ -4.5 V; $I_{SW} = 100$ mA; $V_{CC} = 2.7$ V; see Figure 4		-	0.1	-	Ω

- Measured at identical V $_{CC},$ temperature and input voltage. Typical values are measured at $\rm T_{amb}$ = 25 $^{\circ}C.$

10.3 ON resistance test circuit and graphs



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11 Dynamic characteristics

Table 9. Dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit see Figure 7.

Symbol	Parameter Conditions			T _{amb} =	+85 °C	Unit	
					Typ ^[1]	Max	
t _{en}	enable time	nS to nZ; see Figure 5					
		V _{CC} = 2.7 V to 3.6 V	[2]	-	80	160	ns
		V _{CC} = 3.6 V to 4.3 V	[3]	-	70	120	ns
t _{dis}	disable time	nS to nZ; see Figure 5					
		V _{CC} = 2.7 V to 3.6 V	[2]	-	25	50	ns
		V _{CC} = 3.6 V to 4.3 V	[3]	-	25	50	ns
t _{b-m}	break-before-make time	see Figure 6	[4]				
		V _{CC} = 2.7 V to 3.6 V		15	55	-	ns
		V _{CC} = 3.6 V to 4.3 V		12	45	-	ns

11.1 Waveform and test circuits

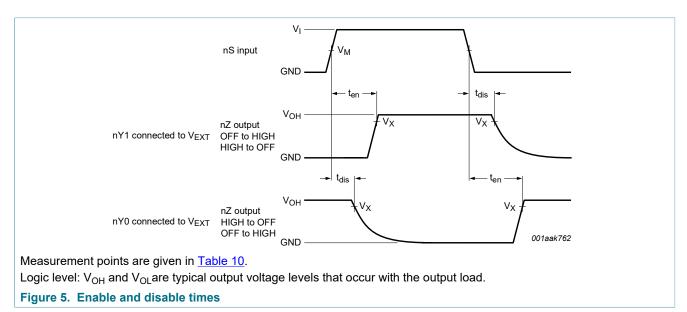


Table 10. Measurement points

Supply voltage	Input	Output	
V _{CC}	V _M	VI	V _X
2.7 V to 4.3 V	0.5V _{CC}	V _{CC}	0.9V _{OH}

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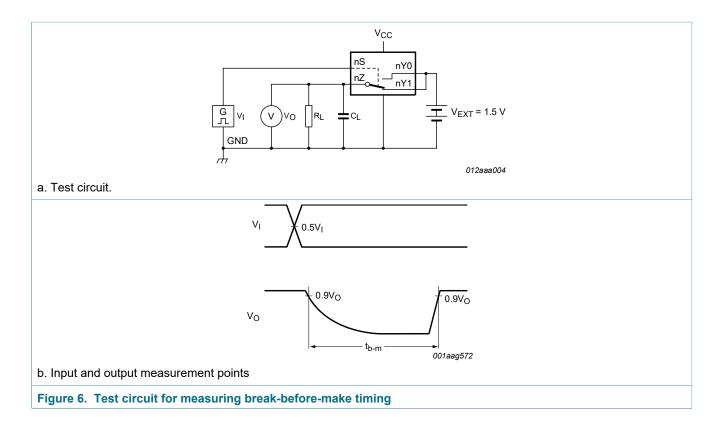
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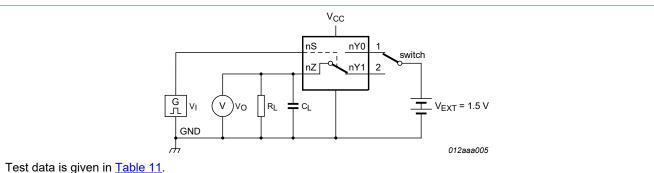
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Typical values are measured at T_{amb} = 25 °C. Typical values are measured at V_{CC} = 3.3 V. Typical values are measured at V_{CC} = 4.3 V.

^[2] [3]

Guaranteed by design.





Definitions test circuit:

 R_{l} = Load resistance.

C_L = Load capacitance including jig and probe capacitance.

 V_{EXT} = External voltage for measuring switching times.

Figure 7. Test circuit for measuring switching times

Table 11. Test data

Supply voltage	Input I		Load		
V _{CC}	VI	t _r , t _f	C _L	R _L	
2.7 V to 4.3 V	V _{CC}	≤ 2.5 ns	35 pF	50 Ω	

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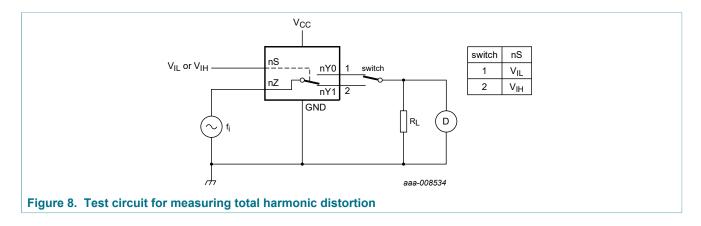
11.2 Additional dynamic characteristics

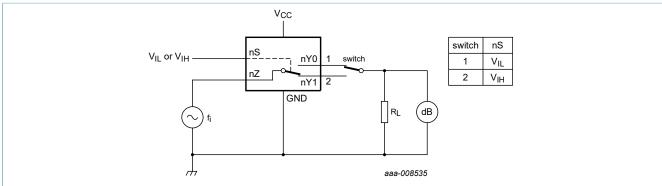
Table 12. Additional dynamic characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); V_I = GND or V_{CC} (unless otherwise specified); t_r = $t_f \le 2.5$ ns; T_{amb} = 25 °C.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
THD	total harmonic	f_i = 20 Hz to 20 kHz; R_L = 32 Ω ; see <u>Figure 8</u>				
	distortion	V _{CC} = 2.7 V; V _I = 2 V (p-p)	-	0.07	-	%
		V _{CC} = 4.3 V; V _I = 2 V (p-p)	-	0.03	-	%
f _(-3dB)	-3 dB frequency	R_L = 50 Ω; see <u>Figure 9</u>				
	response	V _{CC} = 2.7 V to 4.3 V	-	100	-	MHz
α_{iso}	isolation (OFF-state)	f_i = 100 kHz; R_L = 50 Ω; see Figure 10				
		V _{CC} = 2.7 V to 4.3 V	-	-60	-	dB
Xtalk	crosstalk	between switches; f_i = 100 kHz; R_L = 50 Ω ; see Figure 11				
		V _{CC} = 2.7 V to 4.3 V	-	-60	-	dB
Q _{inj}	charge injection	f_i = 1 MHz; C_L = 0.1 nF; R_L = 1 M Ω ; V_{gen} = 0 V; R_{gen} = 0 Ω ; see Figure 12				
		V _{CC} = 2.7 V	-	3	-	рС
		V _{CC} = 3.3 V	-	4	-	рС
		V _{CC} = 4.3 V	-	5	-	рС

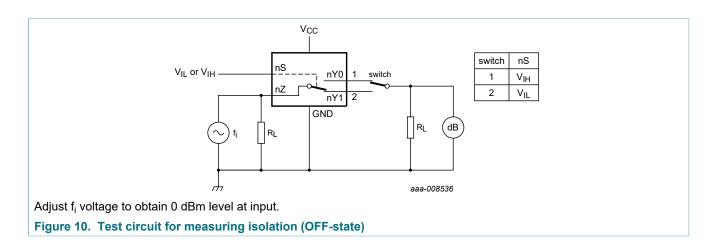
11.3 Test circuits

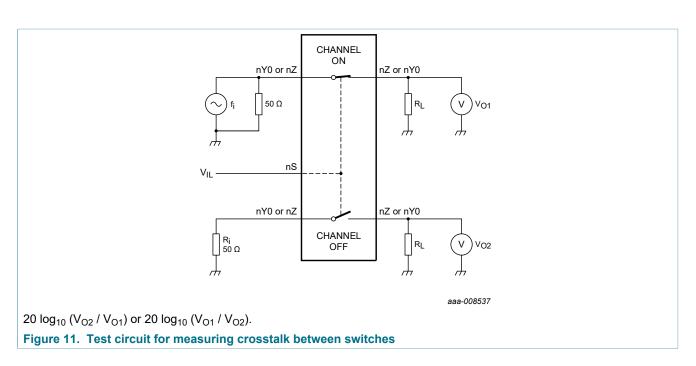


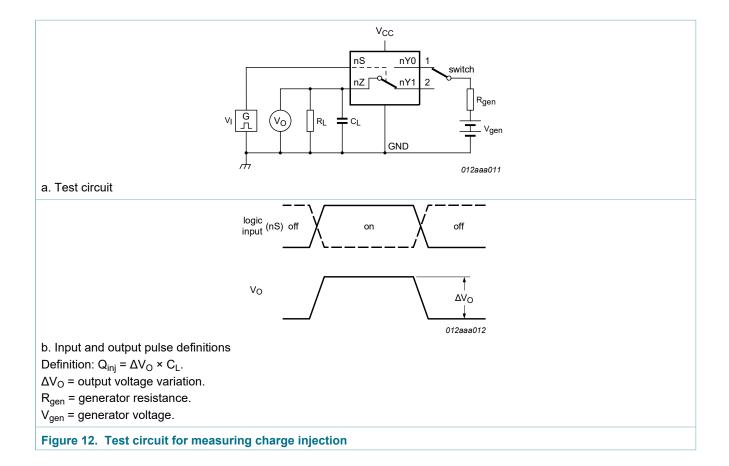


Adjust f_i voltage to obtain 0 dBm level at output. Increase f_i frequency until dB meter reads -3 dB.

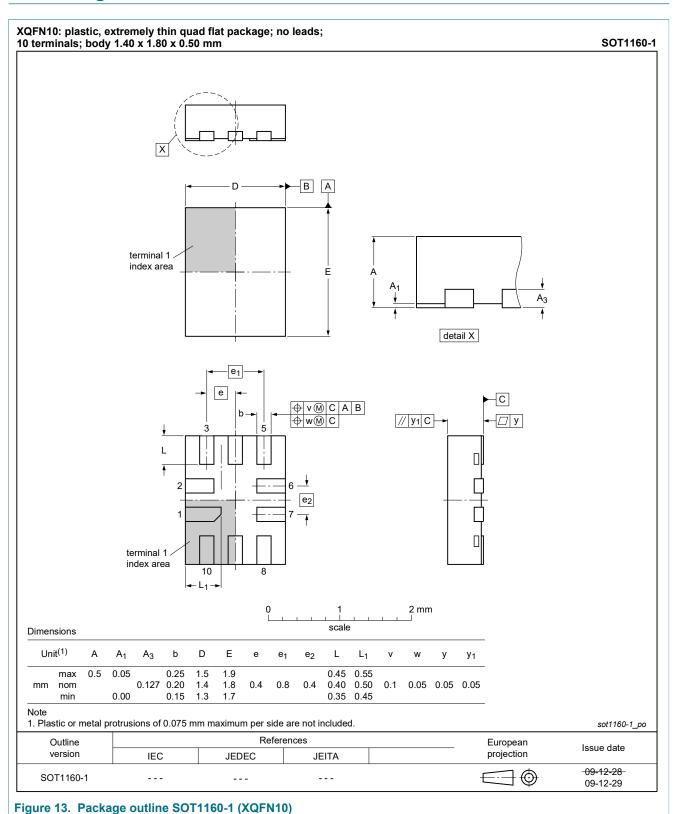
Figure 9. Test circuit for measuring the frequency response when channel is in ON-state







12 Package outline



13 Abbreviations

Table 13. Abbreviations

Acronym	Description
CDM	Charged Device Model
CMOS	Complementary Metal-Oxide Semiconductor
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MM	Machine Model
TTL	Transistor-Transistor Logic
UART	Universal Asynchronous Receiver/Transmitter
USB	Universal Serial Bus

14 Revision history

Table 14. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
NX5L2750CGU v.2.1	20200212	Product data sheet	-	NX5L2750C v.2	
Modifications:		ated look and feel named NX5L2750CGU the	roughout data sheet	,	
NX5L2750C v.2	20140507	Product data sheet	-	NX5L2750C v.1	
Modifications:	• <u>Table 7</u> : minim	Updated by adding the following values: • <u>Table 7</u> : minimum V _{IH} level added at V _{CC} = 4.3 V to 5.0 V • <u>Table 7</u> : minimum V _{IL} level added at V _{CC} = 4.3 V to 5.0 V			
NX5L2750C v.1	20130906	Product data sheet	-	-	

15 Legal information

15.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Analog switch with negative swing audio capability

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